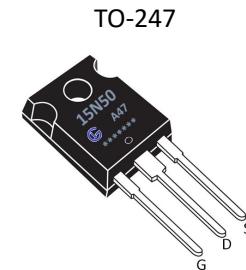


**General Description:**

GL15N50A47 the silicon N-channel Enhanced VDMOSFETS, is obtained by the self-aligned planar Technology which reduce the conduction loss, improve switching performance and enhance the avalanche energy. The transistor can be used in various power switching circuit for system miniaturization and higher efficiency. The package form is TO-247, which accords with the RoHS standard.

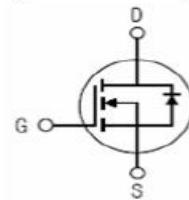
V <sub>DSS</sub>	500	V
I <sub>D</sub>	15	A
P <sub>D</sub> (T <sub>C</sub> =25 °C)	180	W
R <sub>DS(ON)typ</sub>	0.29	Ω


**Features:**

- Fast Switching
- Low Gate Charge and Rdson
- Low Reverse transfer capacitances
- 100% Single Pulse avalanche energy Test

**Applications:**

- Automotive, DC Motor Control and Class D Amplifier.

**Inner Equivalent Principium Chart**

**Absolute (T<sub>c</sub>=25°C unless otherwise specified):**

Symbol	Parameter	Rating	Units
V <sub>DSS</sub>	Drain-to-Source Voltage	500	V
I <sub>D</sub>	Continuous Drain Current	15	A
	Continuous Drain Current T <sub>c</sub> = 100 °C	9.5	A
I <sub>DM</sub> <sup>a1</sup>	Pulsed Drain Current	60	A
V <sub>GS</sub>	Gate-to-Source Voltage	±30	V
E <sub>AS</sub> <sup>a2</sup>	Single Pulse Avalanche Energy	1000	mJ
E <sub>AR</sub> <sup>a1</sup>	Avalanche Energy ,Repetitive	200	mJ
I <sub>AR</sub> <sup>a1</sup>	Avalanche Current	6.3	A
dv/dt <sup>a3</sup>	Peak Diode Recovery dv/dt	5.0	V/ns
P <sub>D</sub>	Power Dissipation	180	W
	Derating Factor above 25°C	1.44	W/°C
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature Range	150, -55 to 150	°C
T <sub>L</sub>	Maximum Temperature for Soldering	300	°C



# GL15N50A47

## GL Silicon N-Channel Power MOSFET

**Electrical Characteristics** ( $T_c=25^\circ C$  unless otherwise specified):

OFF Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$V_{DSS}$	Drain to Source Breakdown Voltage	$V_{GS}=0V, I_D=250\mu A$	500	--	--	V
$\Delta V_{DSS}/\Delta T_J$	Bvdss Temperature Coefficient	$I_D=250\mu A$ , Reference $25^\circ C$	--	0.60	--	$V/^\circ C$
$I_{DSS}$	Drain to Source Leakage Current	$V_{DS}=500V, V_{GS}=0V, T_a=25^\circ C$	--	--	1	$\mu A$
		$V_{DS}=400V, V_{GS}=0V, T_a=125^\circ C$	--	--	250	
$I_{GSS(F)}$	Gate to Source Forward Leakage	$V_{GS}=+30V$	--	--	10	$\mu A$
$I_{GSS(R)}$	Gate to Source Reverse Leakage	$V_{GS}=-30V$	--	--	-10	$\mu A$

ON Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$R_{DS(ON)}$	Drain-to-Source On-Resistance	$V_{GS}=10V, I_D=7.5A$	--	0.29	0.35	$\Omega$
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	3.0	4.0	V
Pulse width $t_p \leq 380\mu s, \delta \leq 2\%$						

Dynamic Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$g_{fs}$	Forward Transconductance	$V_{DS}=15V, I_D=7.5A$	--	18	--	S
$C_{iss}$	Input Capacitance	$V_{GS}=0V, V_{DS}= 25V$	--	2400	--	pF
$C_{oss}$	Output Capacitance	$f=1.0MHz$	--	240	--	
$C_{rss}$	Reverse Transfer Capacitance		--	25.5	--	

Resistive Switching Characteristics						
Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$t_{d(ON)}$	Turn-on Delay Time		--	15	--	ns
$t_r$	Rise Time	$I_D=15A, V_{DD} = 250V$	--	30	--	
$t_{d(OFF)}$	Turn-Off Delay Time	$V_{GS}=10V, R_G=6.1\Omega$	--	50	--	
$t_f$	Fall Time		--	40	--	
$Q_g$	Total Gate Charge	$I_D=15A, V_{DD}=250V$	--	50	--	nC
$Q_{gs}$	Gate to Source Charge	$V_{GS}=10V$	--	12	--	
$Q_{gd}$	Gate to Drain ( "Miller" )Charge		--	20	--	

**Source-Drain Diode Characteristics**

Symbol	Parameter	Test Conditions	Rating			Units
			Min.	Typ.	Max.	
$I_S$	Continuous Source Current (Body Diode)		--	--	15	A
$I_{SM}$	Maximum Pulsed Current (Body Diode)		--	--	60	A
$V_{SD}$	Diode Forward Voltage	$I_S=15\text{A}, V_{GS}=0\text{V}$	--	--	1.5	V
$t_{rr}$	Reverse Recovery Time	$I_S=15\text{A}, T_j = 25^\circ\text{C}$	--	582	--	ns
$Q_{rr}$	Reverse Recovery Charge	$dI_F/dt=100\text{A}/\mu\text{s}, V_{GS}=0\text{V}$	--	4.7	--	$\mu\text{C}$

Pulse width  $t_p \leq 380\mu\text{s}, \delta \leq 2\%$

Symbol	Parameter	Typ.	Units
$R_{\theta JC}$	Junction-to-Case	0.68	$^\circ\text{C}/\text{W}$
$R_{\theta JA}$	Junction-to-Ambient	40	$^\circ\text{C}/\text{W}$

<sup>a1</sup>: Repetitive rating; pulse width limited by maximum junction temperature

<sup>a2</sup>:  $L=10.0\text{mH}, I_D=14\text{A}$ , Start  $T_j=25^\circ\text{C}$

<sup>a3</sup>:  $I_{SD} = 15\text{A}, dI/dt \leq 100\text{A}/\mu\text{s}, V_{DD} \leq BV_{DS}$ , Start  $T_j=25^\circ\text{C}$

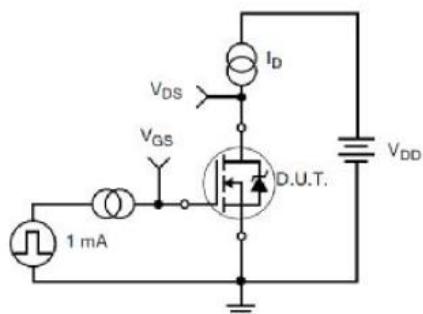
**Test Circuit and Waveform**


Figure 17. Gate Charge Test Circuit

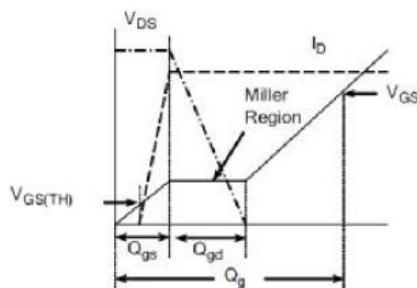


Figure 18. Gate Charge Waveform

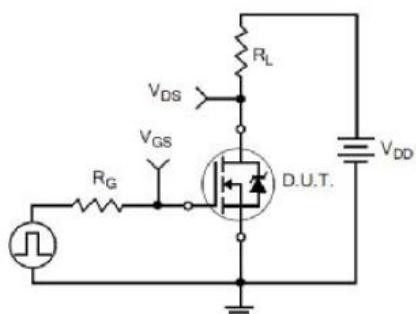


Figure 19. Resistive Switching Test Circuit

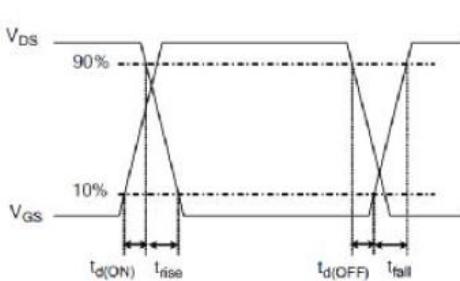
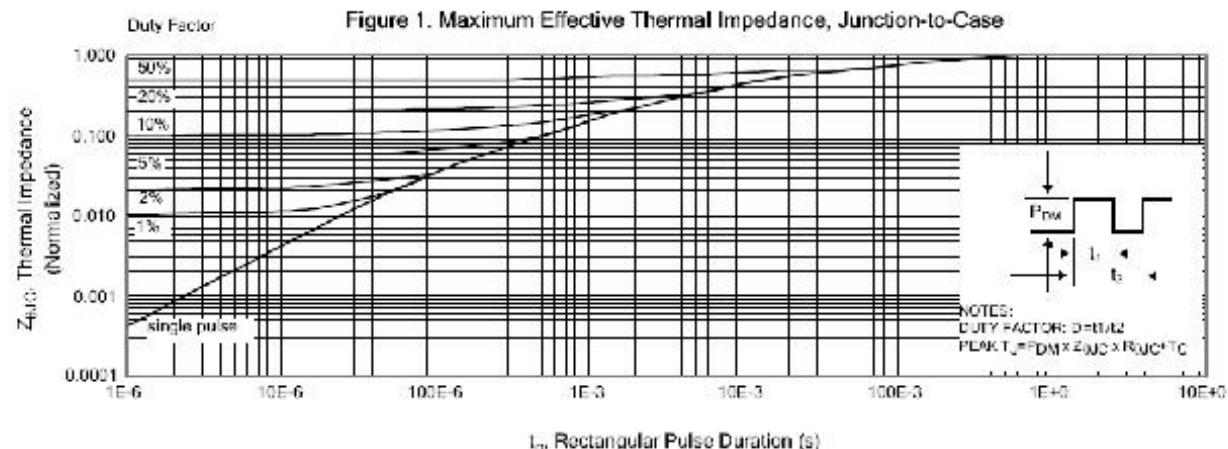
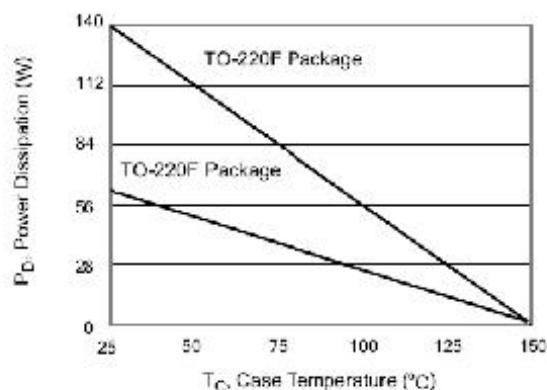


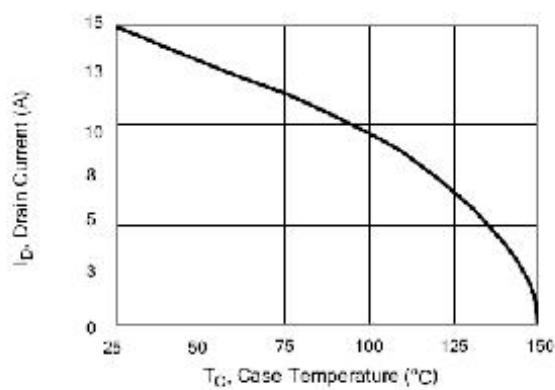
Figure 20. Resistive Switching Waveforms



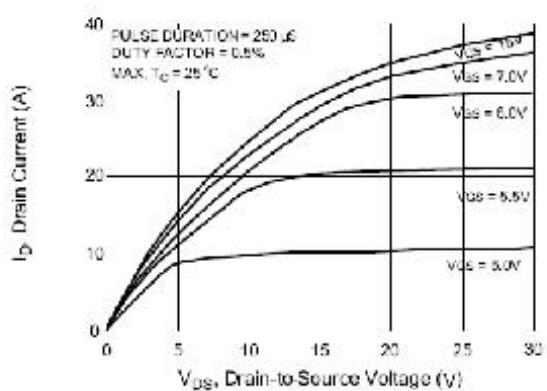
**Figure 2. Maximum Power Dissipation vs Case Temperature**



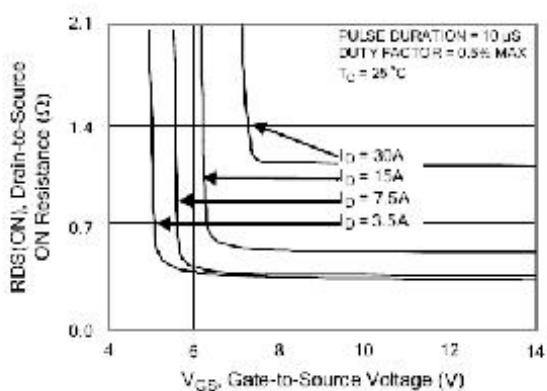
**Figure 3. Maximum Continuous Drain Current vs Case Temperature**

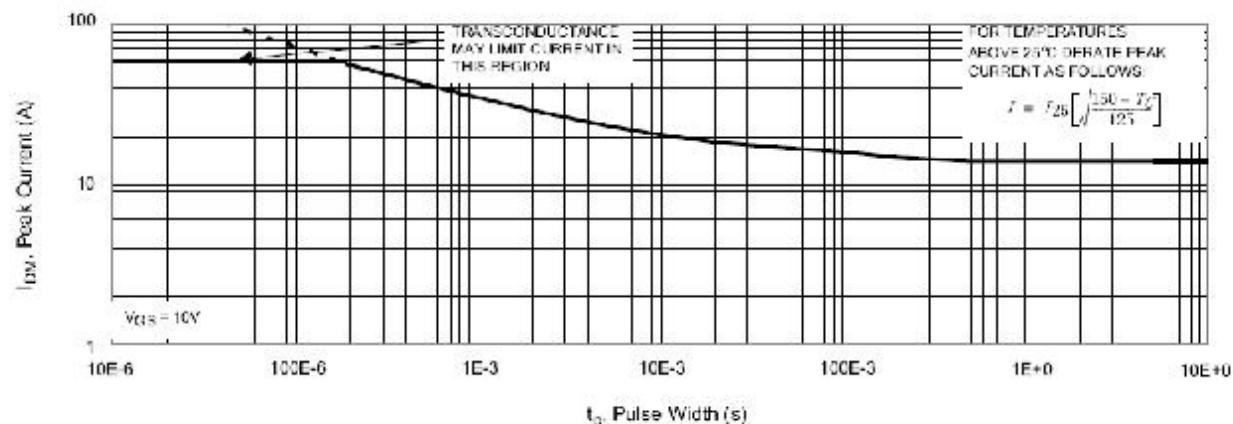
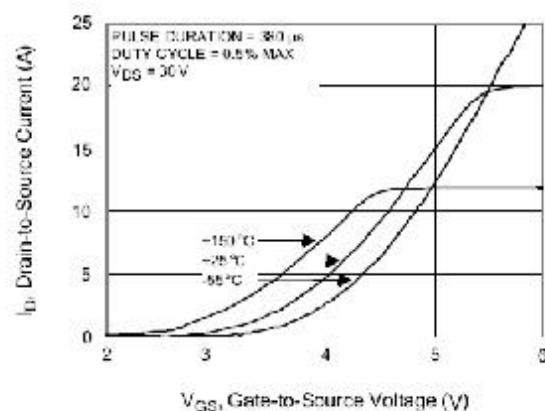
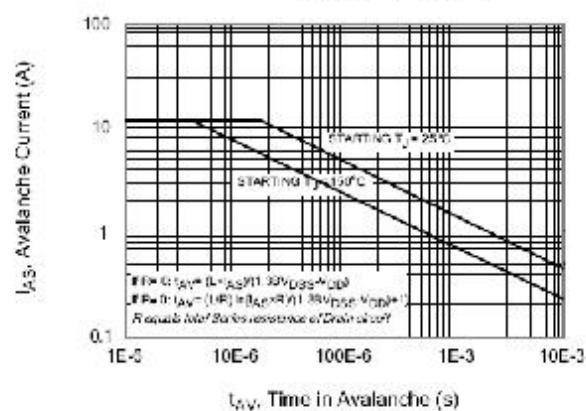
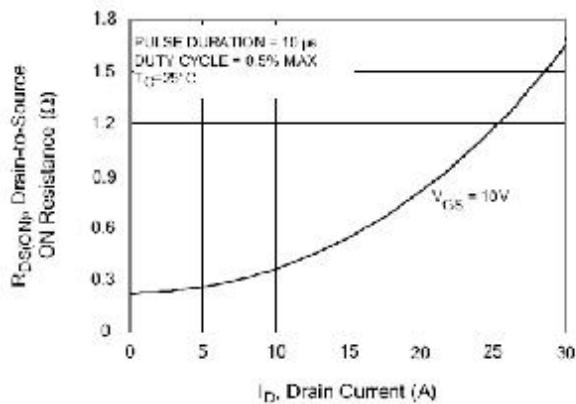
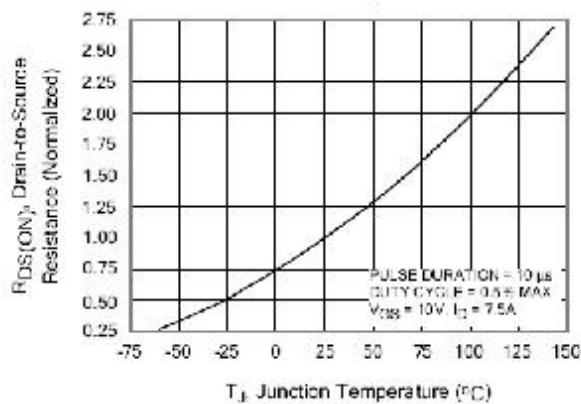


**Figure 4. Typical Output Characteristics**



**Figure 5. Typical Drain-to-Source ON Resistance vs Gate Voltage and Drain Current**



**Figure 6. Maximum Peak Current Capability**

**Figure 7. Typical Transfer Characteristics**

**Figure 8. Unclamped Inductive Switching Capability**

**Figure 9. Typical Drain-to-Source ON Resistance vs Drain Current**

**Figure 10. Typical Drain-to-Source ON Resistance vs Junction Temperature**


***GL Silicon N-Channel Power MOSFET***

Figure 11. Typical Breakdown Voltage vs Junction Temperature

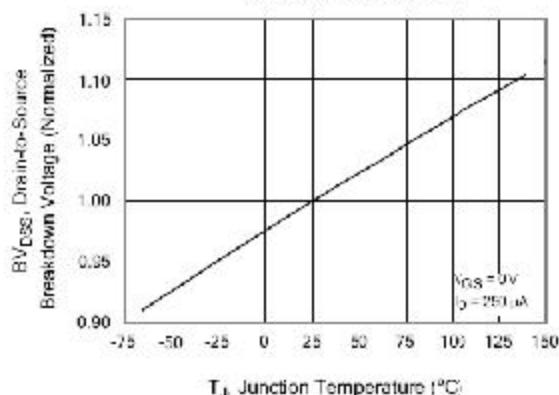


Figure 12. Typical Threshold Voltage vs Junction Temperature

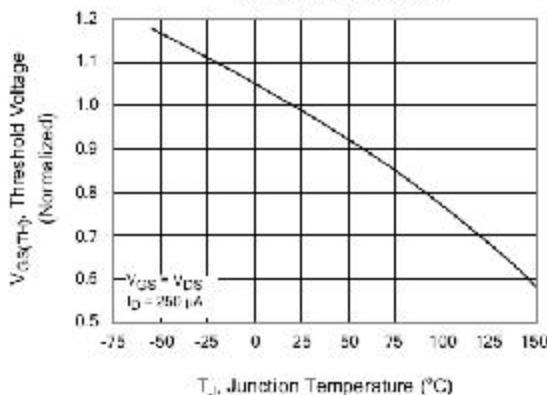


Figure 13. Maximum Forward Bias Safe Operating Area

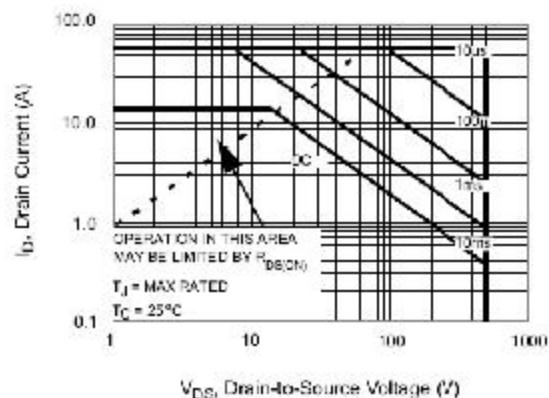


Figure 14. Typical Capacitance vs Drain-to-Source Voltage

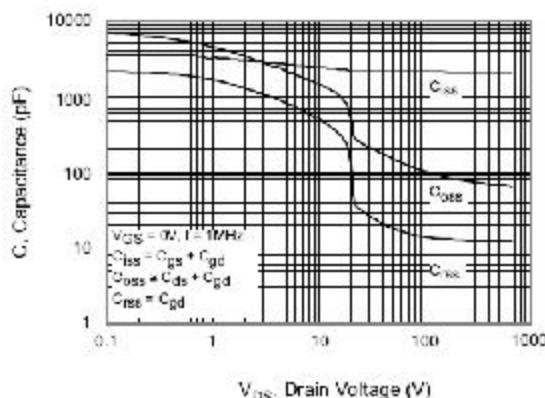


Figure 15. Typical Gate Charge vs Gate-to-Source Voltage

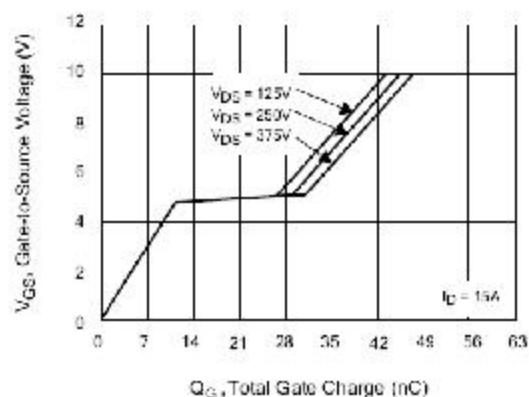
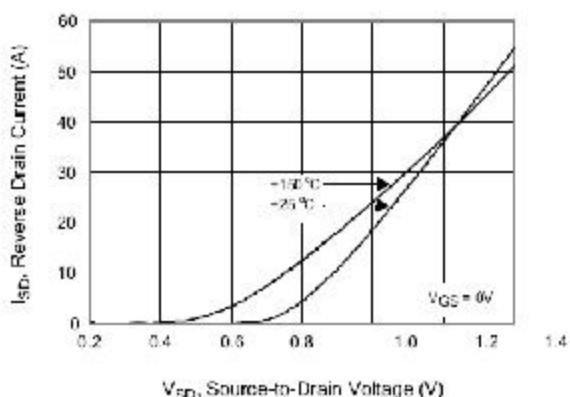


Figure 16. Typical Body Diode Transfer Characteristics



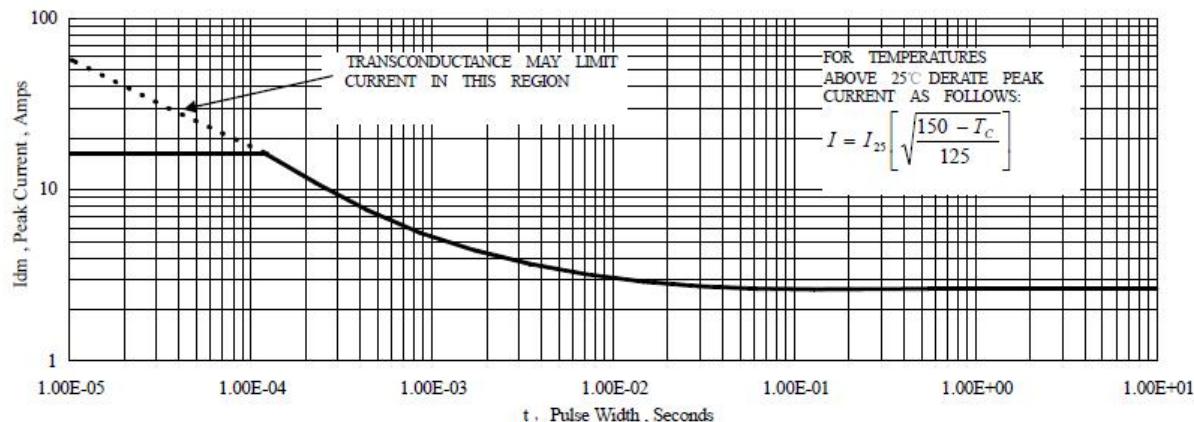


Figure 6 Maximum Peak Current Capability

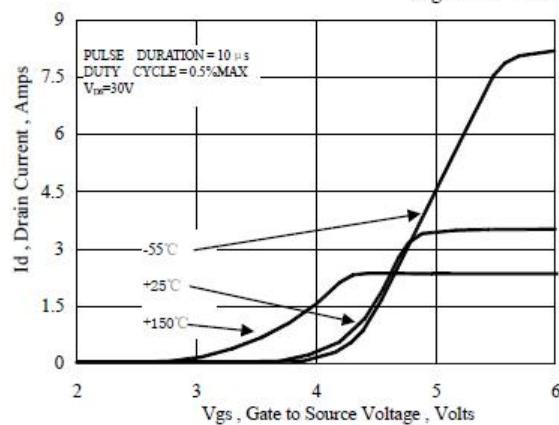


Figure 7 Typical Transfer Characteristics

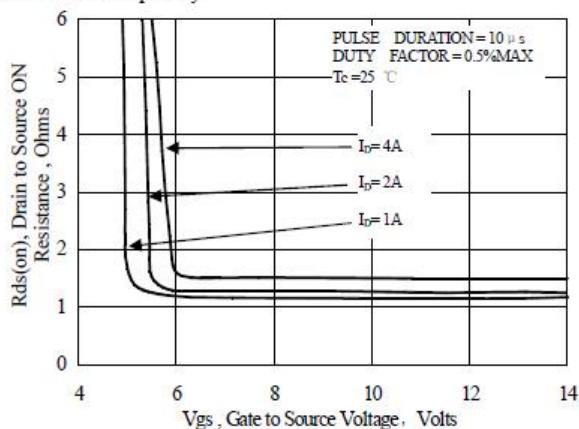


Figure 8 Typical Drain to Source ON Resistance vs Gate Voltage and Drain Current

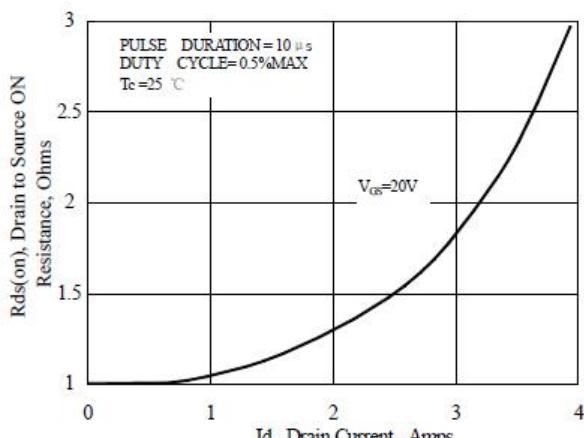


Figure 9 Typical Drain to Source ON Resistance vs Drain Current

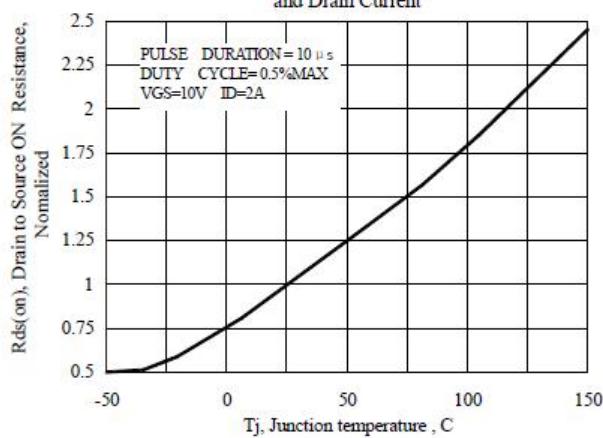


Figure 10 Typical Drain to Source on Resistance vs Junction Temperature